MN3112SA

Vertical Driver for Video-Camera CCD Area-Image-Sensor

Overview

The MN3112SA is a vertical driver LSI incorporating four vertical driver channels and one sub driver channel for a 2-dimensional interline CCD image sensor.

The MN3112SA enables low current dissipation and the part reductions.

Features

• 3V power supply for input section

Applications

• Video cameras

Pin Assignment



Block Diagram



V_{DC}, V_L, GND : Common power supply

 V_{M13}, V_{M24}
 : Binary and tristate independent power supplies for vertical driver section

 V_{HH}, V_H
 : Independent power supplies for sub driver section and vertical driver section

Pin Descriptions

| Pin No. | Symbol | Pin Name | I/O | Function Description |
|---------|--------------------------------------|--|-----|--|
| 6 | V _{DC} | Input section high-level power supply | I | 5V high-level input |
| 15 | GND | Input section low-level power supply | Ι | 5V low-level input |
| 16 | V _H | Vertical driver section high-level power supply | I | High-level input at high-voltage section |
| 20 | V _{HH} | SUB driver section high-level power supply | I | High-level input at high-voltage section |
| 4 19 | V _{M13} V _{M24} | Middle-level power supply | I | $\label{eq:main_state} \begin{array}{c} \mbox{Middle-level input at high-voltage section} \\ \mbox{Input externally to both } V_{M13} \mbox{ and } V_{M24}. \end{array}$ |
| 2 | VL | Low-level power supply | Ι | Low-level input at high-voltage section |
| 9 | IV2 | Transfer pulse input | I | Charge transfer pulse input pin |
| 12 | IV4 | Transfer pulse input | Ι | Charge transfer pulse input pin |
| 7 | IV1 | Transfer pulse input | Ι | Charge transfer pulse input pin |
| 14 | IV3 | Transfer pulse input | I | Charge transfer pulse input pin |
| 8 | CH1 | Charge pulse input | Ι | Charge read pulse input pin |
| 13 | CH1 | Charge pulse input | Ι | Charge read pulse input pin |
| 10 | ISUB | SUB pulse input | Ι | Unwanted charge sourcing pulse input pin |
| 18 | OV4 | Binary transfer pulse output | 0 | Binary transfer pulse output pin (V_{M24}, V_L) |
| 3 | OV2 | Binary transfer pulse output | 0 | Binary transfer pulse output pin (V_{M24}, V_L) |
| 17 | OV3 | Tristate transfer pulse output | 0 | Tristate transfer pulse output pin (V _H , V _{M13} , V _L) |
| 5 | OV1 | Tristate transfer pulse output | 0 | |
| 1 | OSUB | SUB pulse output | 0 | Unwanted charge sourcing pulse output pin (V_{HH}, V_L) |
| 11 | N.C. | No connection | | |

Functions

Binary transfer pulse (vertical driver section)

| IV2 | OV2 |
|-----|-----|
| IV4 | OV4 |
| Н | L |
| L | М |
| | |

Tristate transfer pulse (vertical driver section)

| CH1 | IV1 | OV1 | | |
|-----|-----|-----|--|--|
| CH2 | IV3 | OV3 | | |
| TT | Н | L | | |
| Н | L | М | | |
| T | Н | L | | |
| L | L | Н | | |

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*1 IV1, IV2, IV3, IV4, CH1, CH2

H: V_{DC} L: GND

OV1, OV2, OV3, OV4 H: V_H M: V_{M13} or V_{M24} L: V_L

Unwanted charge sourcing pulse (SUB driver section)

| • • • • | , |
|--------------------|------|
| ISUB | OSUB |
| Н | L |
| L | Н |
| *1 ISUB | |
| H: V _{DC} | |
| L: GND | |
| OSUB | |
| H: V _{HH} | |
| L: V _L | |
| | |

Electrical Characteristics

(1) DC characteristics

 $V_{\rm HH}{=}18.0V$, $V_{\rm H}{=}13.0V$, $V_{\rm M13}{=}V_{\rm M24}{=}1.0V$, $V_{\rm L}{=}$ –7.0V,

 $V_{DC}{=}5.00V$, GND=0.0V , Ta= $-10^\circ C$ to $+70^\circ C$

| Parameter | Symbol | Test Conditions | min | typ | max | Unit |
|-----------------------------------|--------------------|--|---------------------|-----|---------------------|------|
| Quiescent supply current | I _{DDST} | V _I =GND, V _{DC} =3.0V | | | 2.5 | mA |
| | | V _I =GND, V _{DC} =5.0V | | | 4 | |
| Operating supply current | I _{DDDYN} | V _I =GND, V _{DC} | | | 7 | mA |
| Input pins IV1, IV2, IV3, | IV4 , CH | 1 , CH2 , ISUB | | | | |
| Voltage "H" level | V _{IH} | | $0.7 \times V_{DC}$ | | V _{DC} | V |
| Voltage "L" level | V _{IL} | | GND | | $0.3 \times V_{DC}$ | V |
| Input leakage current | I _{LI} | V _I =0 to 5V | | | ±1 | μΑ |
| Output pins 1 (binary output) | OV2 | , OV4 | | | | |
| Output voltage middle level | V _{OM1} | $I_{OM1} = -1 mA$ | 0.9 | | V _{M24} | V |
| Output voltage "L" level | V _{OL1} | I _{OL1} =1mA | VL | | | V |
| Output on-resistance middle level | R _{ONM1} | I _{OM1} =-50mA | | | 40 | Ω |
| Output on-resistance "L" level | R _{ONL1} | I _{OL1} =50mA | | | 40 | Ω |
| Output pins 2 (tristate output) | OV1 | , OV3 | | | | |
| Output voltage "H" level | V _{OH2} | I _{OH2} =-1mA | 12.9 | | V _H | V |
| Output voltage middle level | V _{OM2} | I _{OM2} =-1mA | 0.9 | | V _{M13} | V |
| Output voltage "L" level | V _{OL2} | I _{OL2} =1mA | VL | | | V |
| Output on-resistance "H" level | R _{ONH2} | I _{OH2} =-50mA | | | 50 | Ω |
| Output on-resistance middle level | R _{ONM2} | I _{OM2} =±50mA | | | 40 | Ω |
| Output on-resistance "L" level | R _{ONL2} | I _{OL2} =50mA | | | 40 | Ω |
| Output pin 3 (SUB output) | OSUB | | | | | |
| Output voltage "H" level | V _{OHH3} | I _{OHH3} =-1mA | 17.9 | | V _{HH} | V |
| Output voltage "L" level | V _{OL3} | I _{OL3} =1mA | VL | | — | V |
| Output on-resistance middle level | R _{ONHH3} | I _{ONHH3} =-50mA | | | 50 | Ω |
| Output on-resistance "L" level | R _{ONL3} | I _{ONL3} =50mA | | | 40 | Ω |

(2) AC characteristics

 $V_{\rm HH}{=}18.0V$, $V_{\rm H}{=}13.0V$, $V_{\rm M13}{=}V_{\rm M24}{=}1.0V$, $V_{\rm L}{=}{-}7.0V,$

 $V_{DC}{=}3.0V$, GND=0.0V , Ta=–10°C to +70°C

| Parameter | Symbol | Test Conditions | min | typ | max | Unit | |
|--|--|--------------------------|-----|-----|-----|------|--|
| Output pins 1 (binary output) OV2, OV4 | | | | | | | |
| Transmission delay time | t _{PLM} | No load | | 100 | 200 | | |
| | t _{PML} | "L" level — middle level | | 100 | 200 | IIS | |
| Rise time | t _{TLM} | | | 200 | 200 | 20 | |
| Fall time | t _{TML} | | | 200 | 300 | 115 | |
| Output pins 2 (tristate output | Output pins 2 (tristate output) OV1, OV3 | | | | | | |
| Transmission delay time | t _{PLM} | No load | | 100 | 200 | ns | |
| | t _{PML} | "L" level — middle level | | | | | |
| Transmission delay time | t _{TMH} | No load | | 200 | 400 | | |
| | t _{THM} | middle level — "H" level | | 200 | 400 | IIS | |
| Rise time | t _{TLM} | | | 200 | 200 | 20 | |
| Fall time | t _{TML} | | | 200 | 300 | 115 | |
| Rise time | t _{TMH} | | | 200 | 200 | | |
| Fall time | t _{THM} | | | 200 | 300 | IIS | |
| Output pin 3 (SUB output) | OSUB | | | | | | |
| Transmission delay time | t _{PLHH} | No load | | 100 | 200 | | |
| | t _{PHHL} | "L" level — "H" level | | 100 | 200 | IIS | |
| Rise time | t _{TLHH} | | | 200 | 200 | | |
| Fall time | t _{THHL} | | | 200 | 500 | 115 | |

Application Circuit Example



Note *1: Connect a bypass capacitor as close as possible to each of the MN3112SA's power supply pins (V_{HH} , V_{H} , V_{M13} , V_{M24} , V_L , V_{DC}).

Package Dimensions (Unit: mm)

SSOP020-P-0225



Note) The package of this product will be changed to lead-free type (SSOP020-P-0225C). See the new package dimensions section later of this datasheet.

Usage Notes

- (1) When the sub driver is not used
 - 1. Connect V_{HH} (pin 20) to V_H (pin 16).
 - 2. Connect ISUB (pin 10) to V_{DC} (pin 6) or GND (pin 15).
 - 3. Make no connection for OSUB (pin 1).
- (2) Connect a bypass capacitor as close as possible to MN3112SA power supply pins V_{HH} (pin 20), V_H (pin 16), V_{M13} (pin 4), V_{M24} (pin 19), V_L (pin 2), and V_{DC} (pin 6).
- (3) Guarantee period after unsealing

The guarantee period after opening the dry-sealed packaging is three weeks under the environment conditions of 30°C/70% (temperature/humidity).

(4) The recommended reflow temperature is 230°C.

- New Package Dimensions (Unit: mm)
- SSOP020-P-0225C (Lead-free package)



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